

<b>Notice of References Cited</b>	Application/Control No. 10/692,379		Applicant(s)/Patent Under Reexamination SESEK ET AL.	
	Examiner Gabriel I. Garcia		Art Unit 2625	Page 1 of 1

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*	B	US-2004/0184080	09-2004	Gotoh et al.	358/001.15
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**NON-PATENT DOCUMENTS**

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